

Search Notes

Application/Control No.

10/624,404

Examiner

Mark A. Mais

Applicant(s)/Patent under
Reexamination

CROUCH ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	351-360	3/4/2007	MAM
	373 384		
	385 395.6		
	401 410		
	426 464		
	465 466		
	467 522		
SAME AS	ABOVE	8/7/2007	MAM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Attached Electronic Search	3/4/2007	MAM
See Inventorship Search	8/7/2007	MAM
See Attached Electronic Search [updated]	8/7/2007	MAM